

# **Cypress Semiconductor Mold Compound Qualification Report**

**QTP# 002403 VERSION 1.0**

**January, 2001**

**Sumitomo EME 7320 Mold Compound  
Thin Quad Flat Pack, (TQFP), MSL3  
ASE Taiwan**

## **CYPRESS TECHNICAL CONTACT FOR QUALIFICATION DATA:**

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### PRODUCT QUALIFICATION HISTORY

Qual Report		Description of Qualification Purpose		Date Comp.
000303		Qualify EME 7320 Molding Compound, 160-lead TQFP Package, ASE Taiwan (TAIWN-G)		Feb 00
002403		Qualify EME 7320 Molding Compound, 100-lead TQFP (14 x 14 x 1.4mm), 144-lead (20 x 20 x 1.4mm) and 128-lead (14 x 20 x 1.4mm) Package, ASE Taiwan (TAIWN-G)		Nov 00

MAJOR PACKAGE INFORMATION USED IN THIS QUALIFICATION	
<b>Package Designation:</b>	A100
<b>Package Outline, Type, or Name:</b>	100-pin Thin Quad Flat Pack (TQFP)
<b>Mold Compound Name/Manufacturer:</b>	Sumitomo EME 7320
<b>Mold Compound Flammability Rating:</b>	V-O per UL94
<b>Oxygen Rating Index:</b>	> 28%
<b>Lead Frame Material:</b>	Copper
<b>Lead Finish, Composition / Thickness:</b>	Solder Plate, 85%Sn, 15%Pb
<b>Die Backside Preparation Method/Metallization:</b>	N/A
<b>Die Separation Method:</b>	Wafer Saw
<b>Die Attach Supplier:</b>	Ablestik
<b>Die Attach Material:</b>	Ablestik 8361
<b>Bond Diagram Designation</b>	10-03379
<b>Wire Bond Method:</b>	Thermosonic
<b>Wire Material/Size:</b>	Gold/ 1.3mil
<b>Thermal Resistance Theta JA °C/W:</b>	60°C/W
<b>Package Cross Section Yes/No:</b>	N/A
<b>Assembly Process Flow:</b>	49-41006
<b>Name/Location of Assembly (prime) facility:</b>	ASE Taiwan (TAIWN-G)

ELECTRICAL TEST / FINISH DESCRIPTION	
<b>Test Location:</b>	ASE Taiwan (TAIWN-G)
<b>Fault Coverage:</b>	100%

**Note:** Please contact a Cypress Representative for other packages availability.

MAJOR PACKAGE INFORMATION USED IN THIS QUALIFICATION	
<b>Package Designation:</b>	A128
<b>Package Outline, Type, or Name:</b>	128-pin Thin Quad Flat Pack (TQFP)
<b>Mold Compound Name/Manufacturer:</b>	Sumitomo EME 7320
<b>Mold Compound Flammability Rating:</b>	V-O per UL94
<b>Oxygen Rating Index:</b>	> 28%
<b>Lead Frame Material:</b>	Copper
<b>Lead Finish, Composition / Thickness:</b>	Solder Plate, 85%Sn, 15%Pb
<b>Die Backside Preparation Method/Metallization:</b>	N/A
<b>Die Separation Method:</b>	Wafer Saw
<b>Die Attach Supplier:</b>	Ablestik
<b>Die Attach Material:</b>	Ablestik 8361
<b>Bond Diagram Designation</b>	10-03587
<b>Wire Bond Method:</b>	Thermosonic
<b>Wire Material/Size:</b>	Gold/ 1.0mil
<b>Thermal Resistance Theta JA °C/W:</b>	45°C/W
<b>Package Cross Section Yes/No:</b>	N/A
<b>Assembly Process Flow:</b>	49-41006
<b>Name/Location of Assembly (prime) facility:</b>	ASE Taiwan (TAIWN-G)

ELECTRICAL TEST / FINISH DESCRIPTION	
<b>Test Location:</b>	ASE Taiwan (TAIWN-G)
<b>Fault Coverage:</b>	100%

**Note:** Please contact a Cypress Representative for other packages availability.

MAJOR PACKAGE INFORMATION USED IN THIS QUALIFICATION	
<b>Package Designation:</b>	A144
<b>Package Outline, Type, or Name:</b>	144-pin Thin Quad Flat Pack (TQFP)
<b>Mold Compound Name/Manufacturer:</b>	Sumitomo EME 7320
<b>Mold Compound Flammability Rating:</b>	V-O per UL94
<b>Oxygen Rating Index:</b>	> 28%
<b>Lead Frame Material:</b>	Copper
<b>Lead Finish, Composition / Thickness:</b>	Solder Plate, 85%Sn, 15%Pb
<b>Die Backside Preparation Method/Metallization:</b>	N/A
<b>Die Separation Method:</b>	Wafer Saw
<b>Die Attach Supplier:</b>	Ablestik
<b>Die Attach Material:</b>	Ablestik 8361
<b>Bond Diagram Designation</b>	10-03561
<b>Wire Bond Method:</b>	Thermosonic
<b>Wire Material/Size:</b>	Gold/ 1.3mil
<b>Thermal Resistance Theta JA °C/W:</b>	42°C/W
<b>Package Cross Section Yes/No:</b>	N/A
<b>Assembly Process Flow:</b>	49-41006
<b>Name/Location of Assembly (prime) facility:</b>	ASE Taiwan (TAIWN-G)

ELECTRICAL TEST / FINISH DESCRIPTION	
<b>Test Location:</b>	ASE Taiwan (TAIWN-G)
<b>Fault Coverage:</b>	100%

**Note:** Please contact a Cypress Representative for other packages availability.

**RELIABILITY TESTS PERFORMED PER SPECIFICATION REQUIREMENT**

<b>Stress/Test</b>	<b>Test Condition (Temp/Bias)</b>	<b>Result P/F</b>
High Accelerated Saturation Test	1) QTP #002403, QTP #000303 Bias : 5.5V, 130°C, 85%RH Precondition: JESD22 Moisture Sensitivity Level 3 192 Hrs., 30°C/60%RH	P
Temperature Cycle	1) QTP #002403, QTP #000303 MIL-STD-883C, Method 1010, Condition C, -65°C to 150°C Precondition: JESD22 Moisture Sensitivity Level 3 192 Hrs., 85°C/85%RH	P
High Temperature Storage	1) QTP #000303 165C, no bias	P
Thermal Shock	1) QTP #000303 Cypress Spec 25-00014	P
Acoustic Microscopy, Level 3	1) QTP #002403, QTP #000303 Cypress Spec. 25-00104	P
X-Ray	1) QTP #000303 Cypress Spec 12-00292	P

## Reliability Test Data

QTP #: 002403

Device	Fab Lot #	Assy Lot #	Assy Loc	Duration	Samp	Rej	Failure Mechanism
<b>STRESS: ACOUSTIC - MSL3</b>							
CY7C09579V-AC	4003220	610019982	TAIWN-G	COMP	15	0	
CY7C09379-AC	4004331	610019671	TAIWN-G	COMP	15	0	
CY7C43684-AC	4946059	610019983	TAIWN-G	COMP	15	0	
<b>STRESS: HI-ACCEL SATURATION TEST (130C, 85%RH, 5.5V)PRE COND 192 HR 30C/60%RH</b>							
CY7C09579V-AC	4003220	610019982	TAIWN-G	128H	48	0	
CY7C09379-AC	4004331	610019671	TAIWN-G	128H	45	0	
CY7C43684-AC	4946059	610019983	TAIWN-G	128H	48	0	
<b>STRESS: TC CONDITION C, -65C TO 150C, PRE COND. 192 HRS 30C/60% RH (MSL3)</b>							
CY7C09579V-AC	4003220	610019982	TAIWN-G	300	50	0	
CY7C09579V-AC	4003220	610019982	TAIWN-G	500	50	0	
CY7C09579V-AC	4003220	610019982	TAIWN-G	1000	50	0	
CY7C09379-AC	4004331	610019671	TAIWN-G	300	50	0	
CY7C09379-AC	4004331	610019671	TAIWN-G	500	50	0	
CY7C09379-AC	4004331	610019671	TAIWN-G	1000	50	0	
CY7C43684-AC	4946059	610019983	TAIWN-G	300	49	0	
CY7C43684-AC	4946059	610019983	TAIWN-G	500	49	0	
CY7C43684-AC	4946059	610019983	TAIWN-G	1000	49	0	

## Reliability Test Data

QTP #: 000303

Device	Fab Lot #	Assy Lot #	Assy Loc	Duration	Samp	Rej	Failure Mechanism
<b>STRESS: ACOUSTIC</b>							
CY7C375I-AC	2901582	619909347	TAIWN-G	COMP	15	0	
CY7C375I-AC	2902720	619909600	TAIWN-G	COMP	15	0	
CY7C375I-AC	2902720	619909601	TAIWN-G	COMP	15	0	
<b>STRESS: HI-ACCEL SATURATION TEST (130C, 85%RH, 5.5V)PRE COND 192 HR 30C/60%RH</b>							
CY7C375I-AC	2902720	619909600	TAIWN-G	128	24	0	
<b>STRESS: HIGH TEMP STORAGE, PLASTIC, 165C</b>							
CY7C375I-AC	2901582	619909347	TAIWN-G	336	50	0	
<b>STRESS: TC CONDITION C, -65C TO 150C, PRE COND. 192 HRS 30C/60% RH (MSL3)</b>							
CY7C375I-AC	2901582	619909347	TAIWN-G	300	50	0	
CY7C375I-AC	2901582	619909347	TAIWN-G	500	48	0	
CY7C375I-AC	2901582	619909347	TAIWN-G	1000	48	0	
CY7C375I-AC	2902720	619909600	TAIWN-G	300	50	0	
CY7C375I-AC	2902720	619909600	TAIWN-G	500	50	0	
CY7C375I-AC	2902720	619909600	TAIWN-G	1000	49	0	
CY7C375I-AC	2902720	619909601	TAIWN-G	300	50	0	
CY7C375I-AC	2902720	619909601	TAIWN-G	500	50	0	
CY7C375I-AC	2902720	619909601	TAIWN-G	1000	50	0	
<b>STRESS: THERMAL SHOCK, CONDITION B (150C, -55C)</b>							
CY7C375I-AC	2901582	619909347	TAIWN-G	100	50	0	
CY7C375I-AC	2901582	619909347	TAIWN-G	200	50	0	
<b>STRESS: X-RAY (EXAMPLE: LOOKING FOR WIRE-SWEEP)</b>							
CY7C375I-AC	2901582	619909347	TAIWN-G	COMP	15	0	